

10 A, 600 V short-circuit rugged IGBT

## Features

- Lower on voltage drop ( $V_{CE(sat)}$ )
- Lower  $C_{RES}$  /  $C_{IES}$  ratio (no cross-conduction susceptibility)
- Very soft ultra fast recovery antiparallel diode
- Short-circuit withstand time 10 $\mu$ s

## Description

This IGBT utilizes the advanced PowerMESH™ process resulting in an excellent trade-off between switching performance and low on-state behavior.

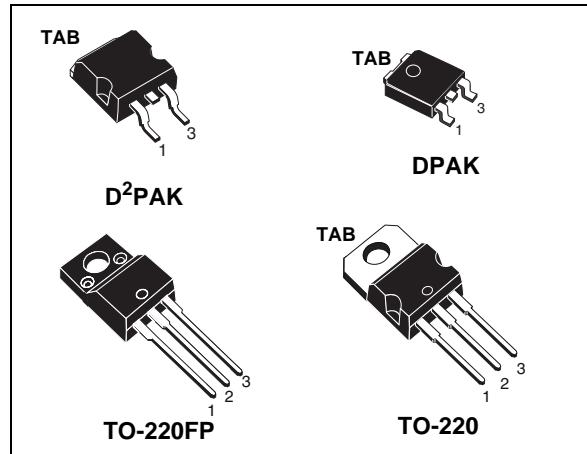


Figure 1. Internal schematic diagram

## Applications

- High frequency motor controls
- SMPS and PFC in both hard switch and resonant topologies
- Motor drives

Table 1. Device summary

Order codes	Marking	Packages	Packaging
STGB10NC60KDT4	GB10NC60KD	D <sup>2</sup> PAK	Tape and reel
STGD10NC60KDT4	GD10NC60KD	DPAK	
STGF10NC60KD	GF10NC60KD	TO-220FP	Tube
STGP10NC60KD	GP10NC60KD	TO-220	

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value			Unit
		D <sup>2</sup> PAK TO-220	DPAK	TO-220FP	
$V_{CES}$	Collector-emitter voltage ( $V_{GE} = 0$ )	600		V	
$I_C^{(1)}$	Continuous collector current at $T_C = 25^\circ\text{C}$	20		9	A
$I_C^{(1)}$	Continuous collector current at $T_C = 100^\circ\text{C}$	10		6	A
$I_{CL}^{(2)}$	Turn-off latching current	30			A
$I_{CP}^{(3)}$	Pulsed collector current	30			A
$V_{GE}$	Gate-emitter voltage	$\pm 20$			V
$I_F$	Diode RMS forward current at $T_c=25^\circ\text{C}$	10			A
$I_{FSM}$	Surge non repetitive forward current $T_p = 10 \text{ ms}$ sinusoidal	20			A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	65	62	25	W
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t=1\text{s}; T_C=25^\circ\text{C}$ )	--		2500	V
$t_{scw}$	Short-circuit withstand time $V_{CE} = 0.5 V_{CES}$ , $T_j = 125^\circ\text{C}$ , $R_G = 10 \Omega$ , $V_{GE} = 12 \text{ V}$	10			$\mu\text{s}$
$T_{stg}$	Storage temperature	– 55 to 150			$^\circ\text{C}$
$T_j$	Operating junction temperature				

1. Calculated according to the iterative formula

$$I_C(T_C) = \frac{T_{j(\max)} - T_C}{R_{thj-c} \times V_{CE(sat)(\max)}(T_{j(\max)}, I_C(T_C))}$$

2.  $V_{clamp} = 80\% V_{CES}$ ,  $V_{GE} = 15 \text{ V}$ ,  $R_G = 10 \Omega$ ,  $T_J = 150^\circ\text{C}$

3. Pulse width limited by maximum junction temperature and turn-off within RBSOA

**Table 3. Thermal data**

Symbol	Parameter	Value			Unit
		TO-220 D <sup>2</sup> PAK	DPAK	TO-220FP	
R <sub>thj-case</sub>	Thermal resistance junction-case IGBT	1.9	2	5	°C/W
R <sub>thj-case</sub>	Thermal resistance junction-case diode	4	4.5	7	
R <sub>thj-amb</sub>	Thermal resistance junction-ambient	62.5	100	62.5	

## 2 Electrical characteristics

( $T_j = 25^\circ\text{C}$  unless otherwise specified)

**Table 4. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{CES}}$	Collector-emitter breakdown voltage ( $V_{\text{GE}} = 0$ )	$I_C = 1\text{mA}$	600			V
$V_{\text{CE}(\text{sat})}$	Collector-emitter saturation voltage	$V_{\text{GE}} = 15\text{V}, I_C = 5\text{A}$ $V_{\text{GE}} = 15\text{V}, I_C = 5\text{A}, T_j = 125^\circ\text{C}$		2.2 1.8	2.5	V V
$V_{\text{GE}(\text{th})}$	Gate threshold voltage	$V_{\text{CE}} = V_{\text{GE}}, I_C = 250\mu\text{A}$	4.5		6.5	V
$I_{\text{CES}}$	Collector cut-off current ( $V_{\text{GE}} = 0$ )	$V_{\text{CE}} = 600\text{ V}$ $V_{\text{CE}} = 600\text{ V}, T_j = 125^\circ\text{C}$			150 1	$\mu\text{A}$ mA
$I_{\text{GES}}$	Gate-emitter leakage current ( $V_{\text{CE}} = 0$ )	$V_{\text{GE}} = \pm 20\text{V}$			$\pm 100$	nA
$g_{\text{fs}}^{(1)}$	Forward transconductance	$V_{\text{CE}} = 15\text{V}, I_C = 5\text{A}$		15		S

1. Pulse test: pulse duration < 300  $\mu\text{s}$ , duty cycle < 2 %

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{\text{ies}}$	Input capacitance			380		pF
$C_{\text{oes}}$	Output capacitance		-	46	-	pF
$C_{\text{res}}$	Reverse transfer capacitance	$V_{\text{CE}} = 25\text{V}, f = 1\text{MHz}, V_{\text{GE}} = 0$		8.5		pF
$Q_g$	Total gate charge	$V_{\text{CE}} = 390\text{V}, I_C = 5\text{A}, V_{\text{GE}} = 15\text{V}$		19		nC
$Q_{\text{ge}}$	Gate-emitter charge		-	5	-	nC
$Q_{\text{gc}}$	Gate-collector charge	(see Figure 19)		9		nC

**Table 6. Switching on/off (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$ ( $di/dt$ ) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V$ (see Figure 20)	-	17 6 655	-	ns ns A/ $\mu$ s
$t_{d(on)}$ $t_r$ ( $di/dt$ ) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V,$ $T_j = 125^\circ C$ (see Figure 20)	-	16.5 6.5 575	-	ns ns A/ $\mu$ s
$t_r(V_{off})$ $t_{d(off)}$ $t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390V, I_C = 5A,$ $R_{GE} = 10\Omega, V_{GE} = 15V$ (see Figure 20)	-	33 72 82	-	ns ns ns
$t_r(V_{off})$ $t_{d(off)}$ $t_f$	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390V, I_C = 5A,$ $R_{GE} = 10\Omega, V_{GE} = 15V,$ $T_j = 125^\circ C$ (see Figure 20)	-	60 106 136	-	ns ns ns

**Table 7. Switching energy (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{on}^{(1)}$ $E_{off}^{(2)}$ $E_{ts}$	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V$ (see Figure 20)	-	55 85 140	-	$\mu$ J $\mu$ J $\mu$ J
$E_{on}^{(1)}$ $E_{off}^{(2)}$ $E_{ts}$	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V,$ $T_j = 125^\circ C$ (see Figure 20)	-	87 162 249	-	$\mu$ J $\mu$ J $\mu$ J

1.  $E_{on}$  is the turn-on losses when a typical diode is used in the test circuit in figure 2. If the IGBT is offered in a package with a co-pak diode, the co-pak diode is used as external diode. IGBTs & Diode are at the same temperature ( $25^\circ C$  and  $125^\circ C$ )
2. Turn-off losses include also the tail of the collector current

**Table 8. Collector-emitter diode**

Symbol	Parameter	Test conditions	Min	Typ.	Max.	Unit
$V_F$	Forward on-voltage	$I_F=5\text{ A}$ $I_F=5\text{ A}, T_j=125\text{ }^\circ\text{C}$	-	2 1.6	-	V V
$t_{rr}$	Reverse recovery time	$I_F=5\text{ A}, V_R=40\text{ V},$ $di/dt=100\text{ A}/\mu\text{s}$	-	22	-	ns
$Q_{rr}$	Reverse recovery charge	(see <i>Figure 5</i> )	-	14	-	nC
$I_{rrm}$	Reverse recovery current		-	1.3	-	A
$t_{rr}$	Reverse recovery time	$I_F=5\text{ A}, V_R=40\text{ V},$ $T_j=125\text{ }^\circ\text{C}, di/dt=100\text{ A}/\mu\text{s}$	-	35	-	ns
$Q_{rr}$	Reverse recovery charge	(see <i>Figure 5</i> )	-	40	-	nC
$I_{rrm}$	Reverse recovery current		-	2.2	-	A

## 2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

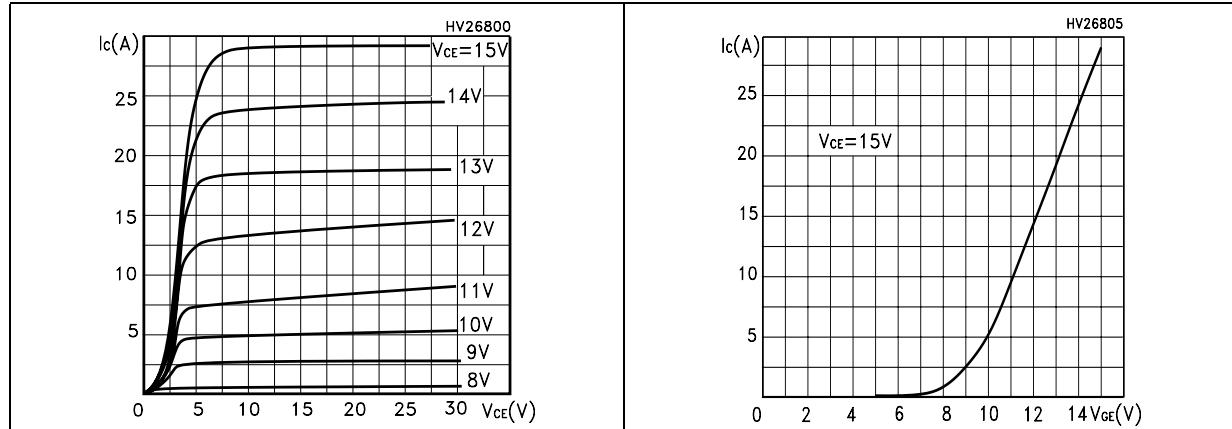


Figure 4. Transconductance

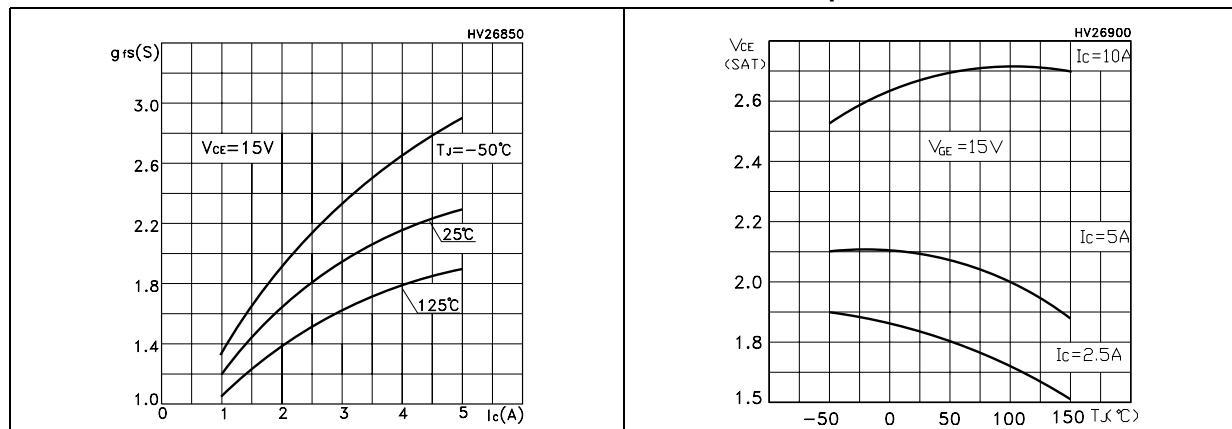


Figure 6. Gate charge vs gate-source voltage

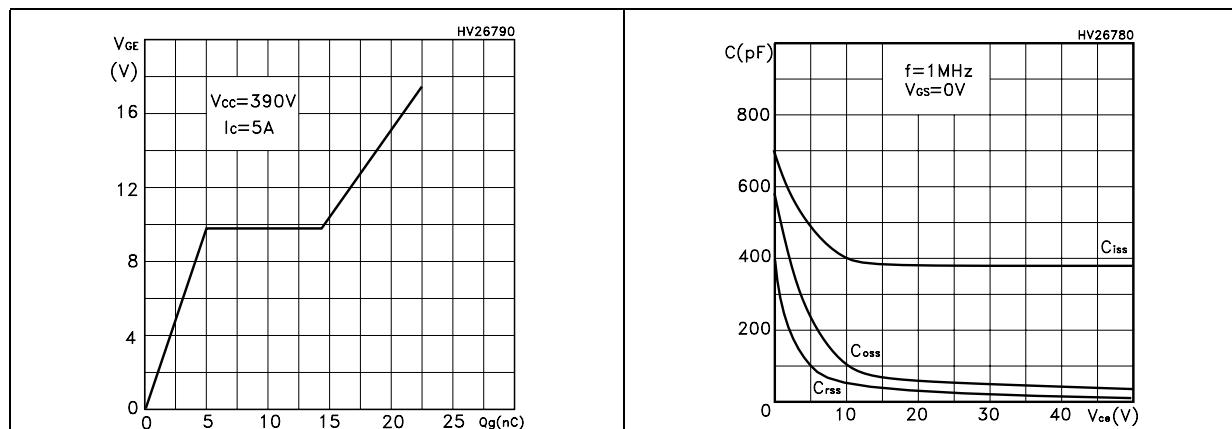


Figure 3. Transfer characteristics

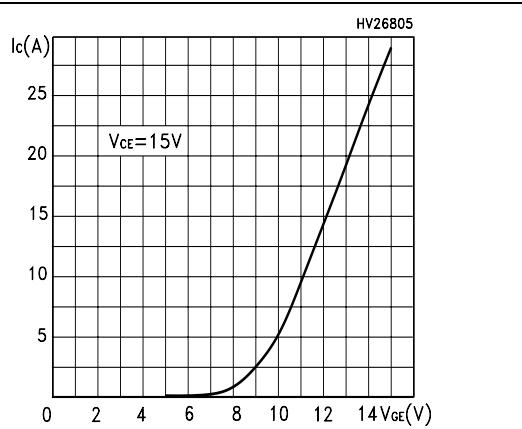


Figure 5. Collector-emitter on voltage vs temperature

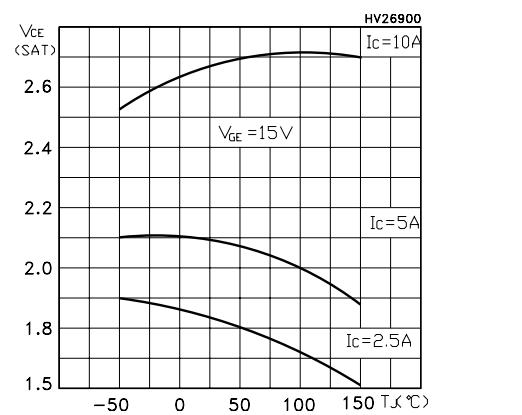
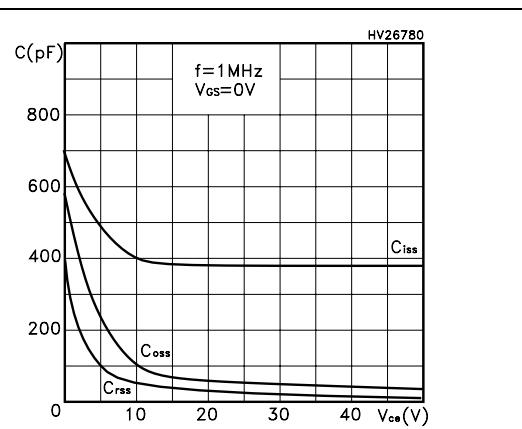
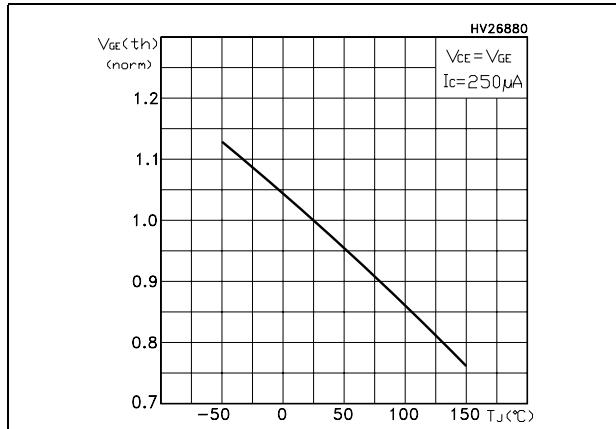
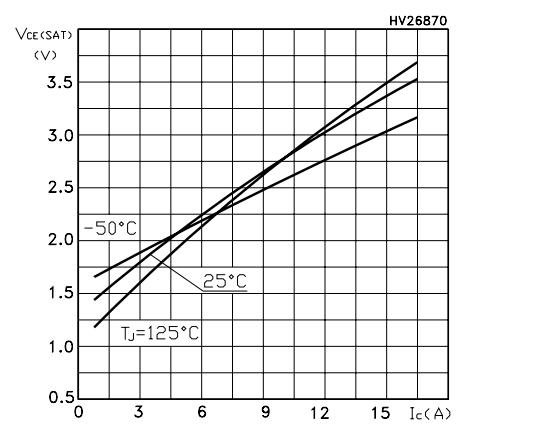
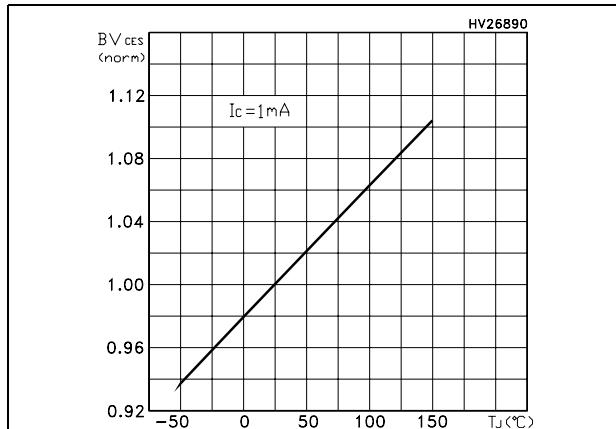
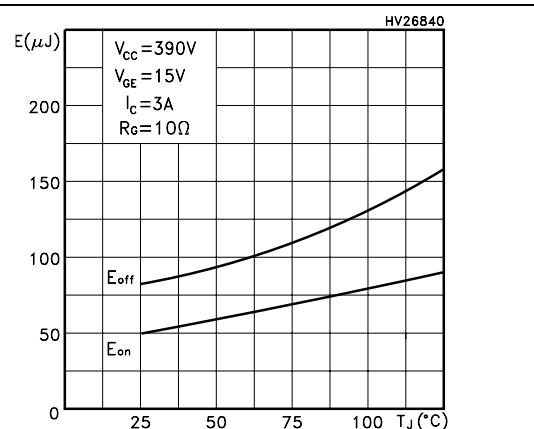
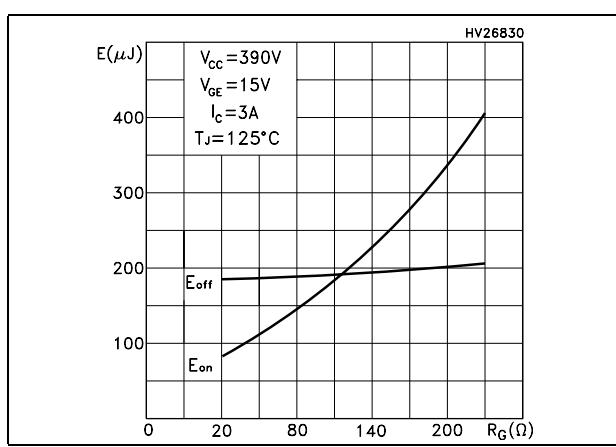
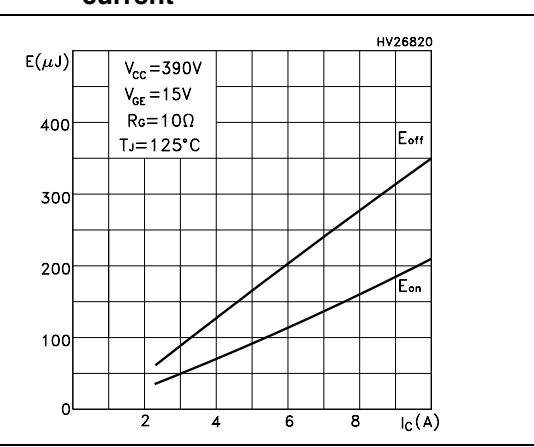
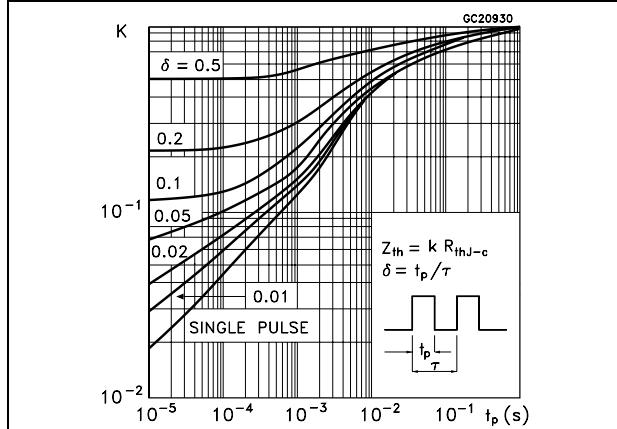


Figure 7. Capacitance variations



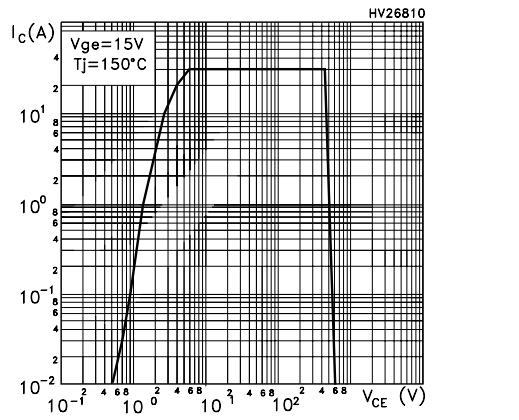
**Figure 8. Normalized gate threshold voltage vs temperature****Figure 9. Collector-emitter on voltage vs collector current****Figure 10. Normalized breakdown voltage vs temperature****Figure 11. Switching losses vs temperature****Figure 12. Switching losses vs gate resistance****Figure 13. Switching losses vs collector current**

**Figure 14. Thermal impedance for D<sup>2</sup>PAK,  
DPAK and TO-220**

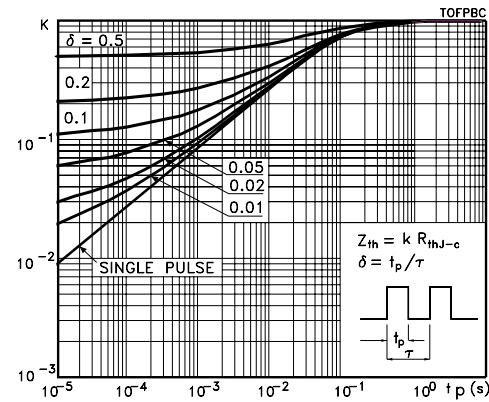
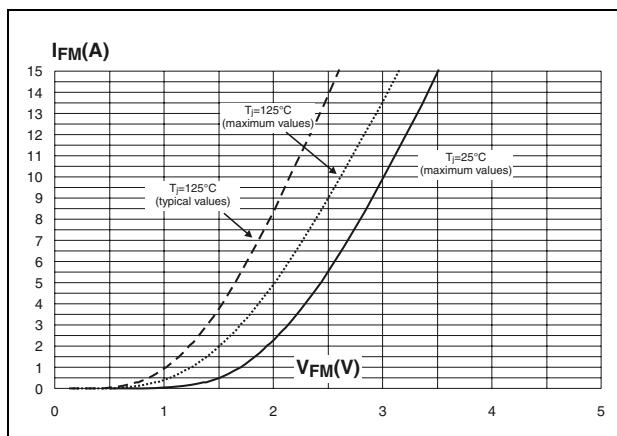


**Figure 16. Emitter-collector diode  
characteristics**

**Figure 15. Turn-off SOA**

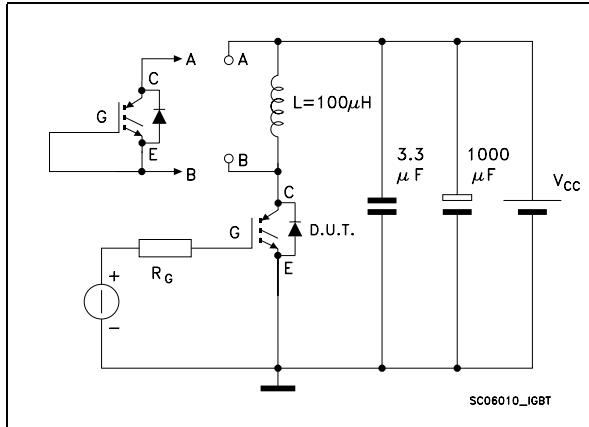


**Figure 17. Thermal impedance for TO-220FP**

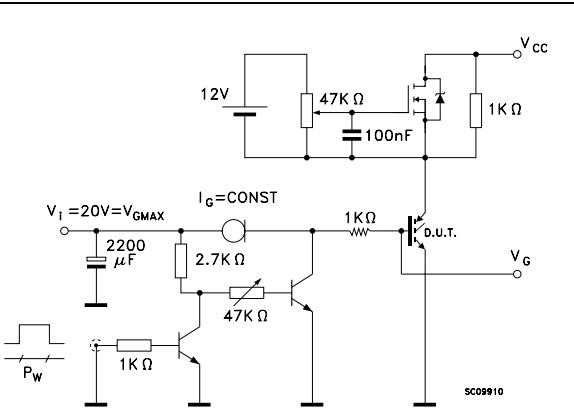


### 3 Test circuits

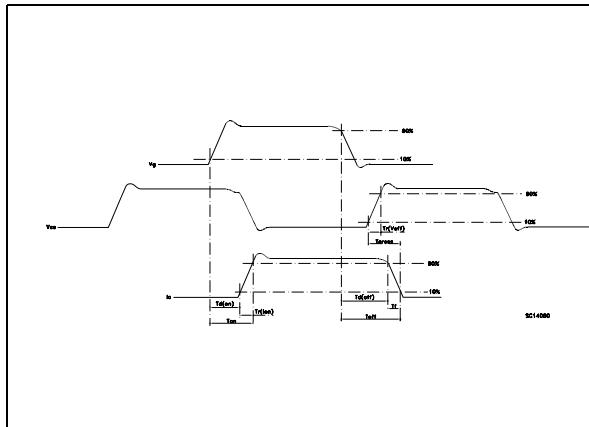
**Figure 18.** Test circuit for inductive load switching



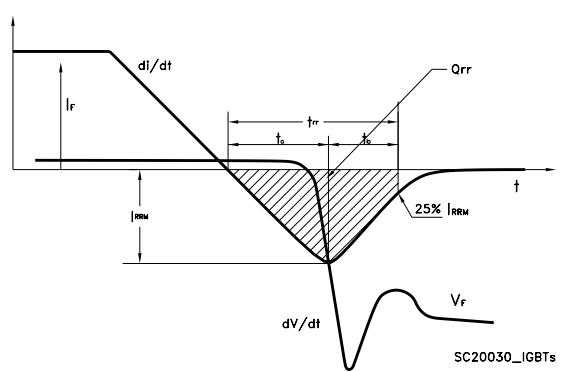
**Figure 19.** Gate charge test circuit



**Figure 20.** Switching waveform



**Figure 21.** Diode recovery time waveform



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK is an ST trademark.

**Table 9. D<sup>2</sup>PAK package mechanical data**

Dim.	mm			inch		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.40		4.60	0.173		0.181
A1	0.03		0.23	0.001		0.009
b	0.70		0.93	0.027		0.037
b2	1.14		1.70	0.045		0.067
c	0.45		0.60	0.017		0.024
c2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1	7.50			0.295		
E	10		10.40	0.394		0.409
E1	8.50			0.334		
e		2.54			0.1	
e1	4.88		5.28	0.192		0.208
H	15		15.85	0.590		0.624
J1	2.49		2.69	0.099		0.106
L	2.29		2.79	0.090		0.110
L1	1.27		1.40	0.05		0.055
L2	1.30		1.75	0.051		0.069
R		0.4			0.016	
V2	0°		8°	0°		8°

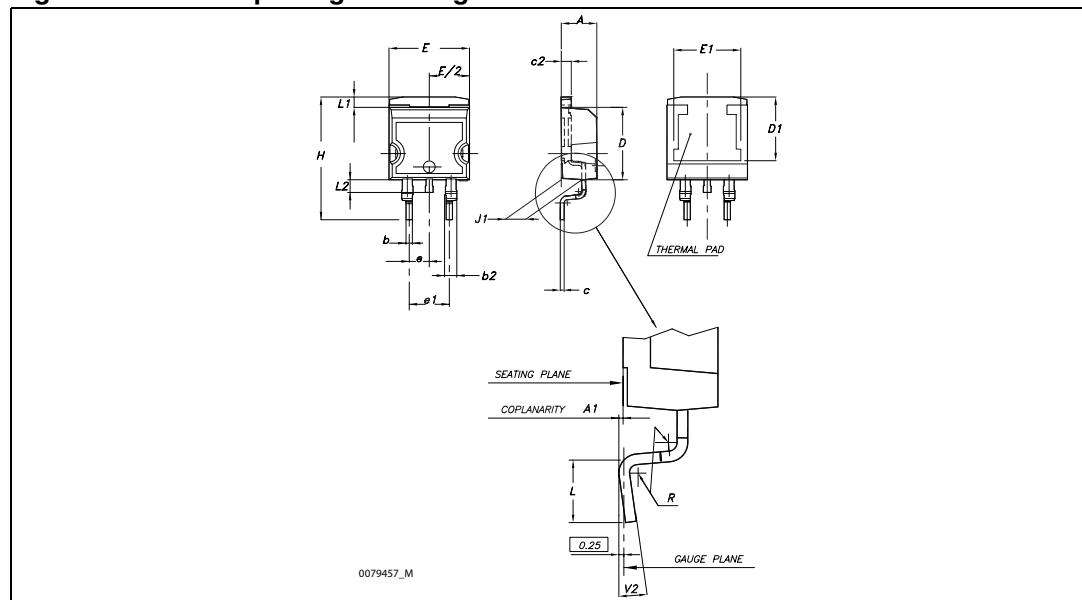
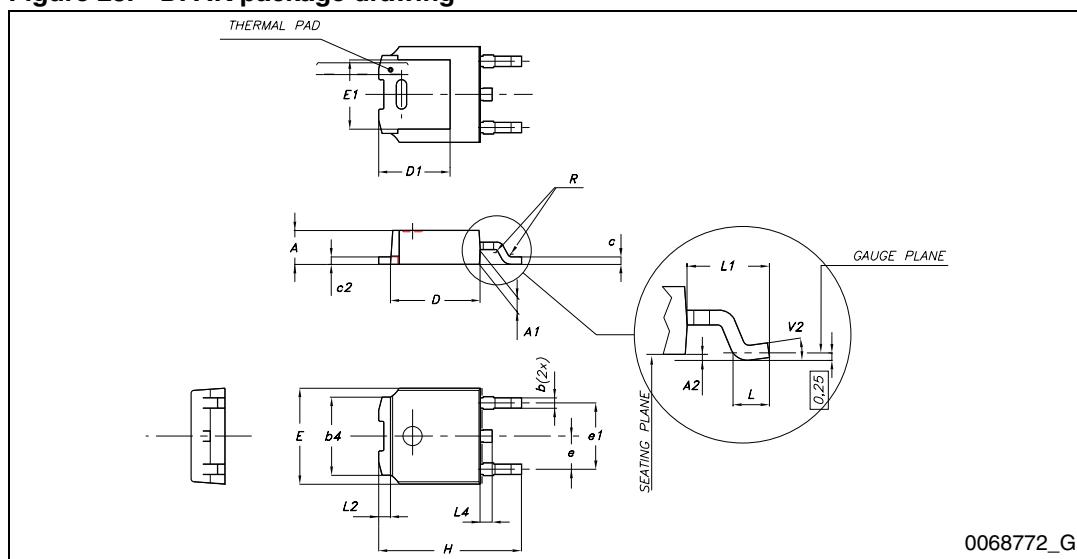
**Figure 22. D<sup>2</sup>PAK package drawing**

Table 10. DPAK package mechanical data

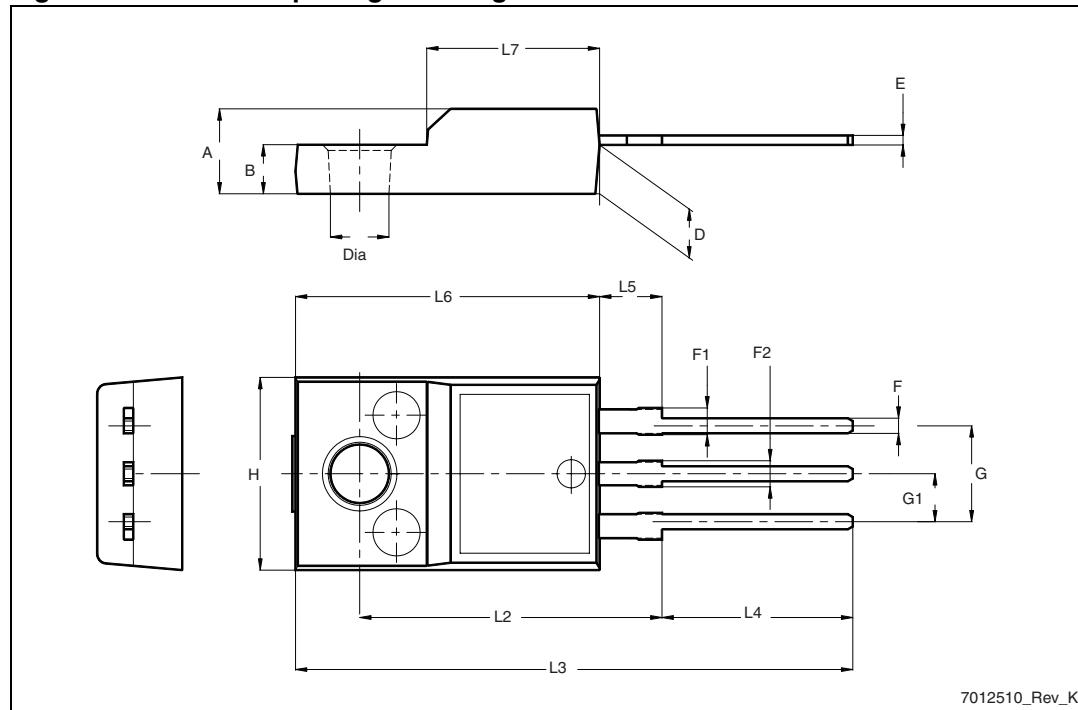
Dim.	mm		
	Min.	Typ	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0 °		8 °

Figure 23. DPAK package drawing



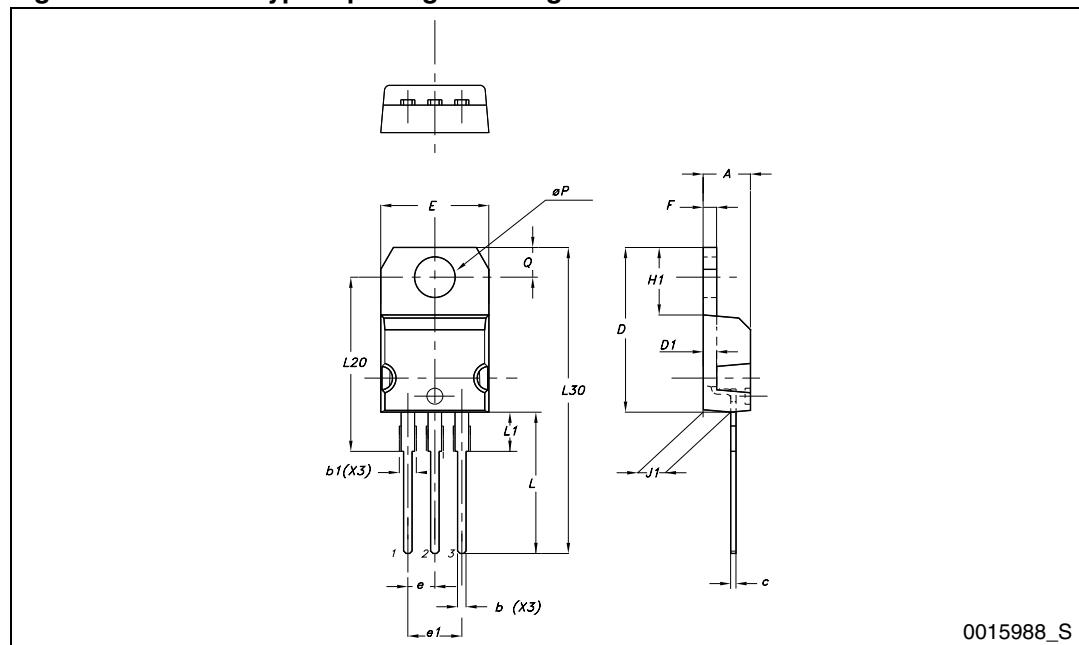
**Table 11.** TO-220FP package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

**Figure 24.** TO-220FP package drawing

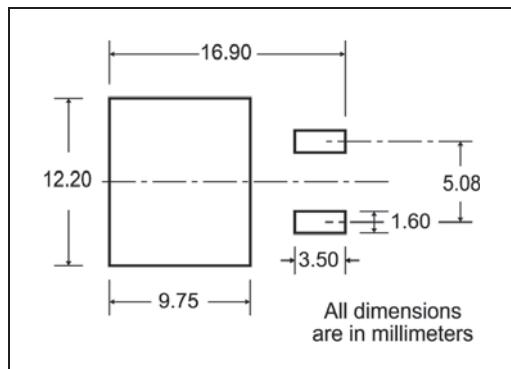
**Table 12. TO-220 type A mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

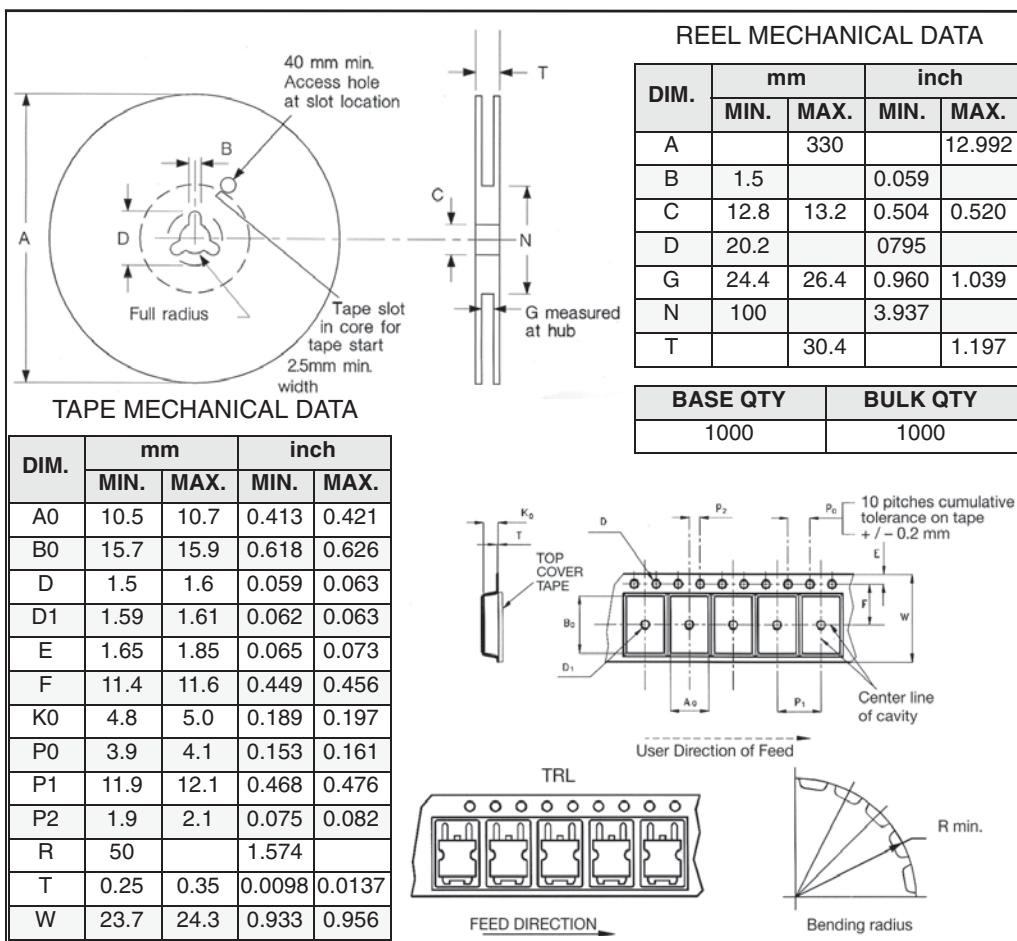
**Figure 25. TO-220 type A package drawing**

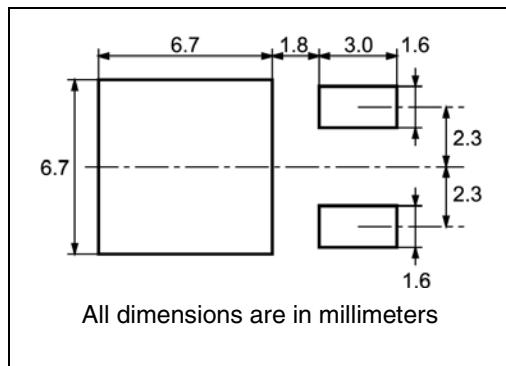
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## 5 Packaging mechanical data

D<sup>2</sup>PAK FOOTPRINT

TAPE AND REEL SHIPMENT



**DPAK FOOTPRINT****TAPE AND REEL SHIPMENT**

REEL MECHANICAL DATA				
DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A		330		12.992
B	1.5		0.059	
C	12.8	13.2	0.504	0.520
D	20.2		0.795	
G	16.4	18.4	0.645	0.724
N	50		1.968	
T		22.4		0.881

BASE QTY	BULK QTY
2500	2500

TAPE MECHANICAL DATA				
DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A <sub>0</sub>	6.8	7	0.267	0.275
B <sub>0</sub>	10.4	10.6	0.409	0.417
B <sub>1</sub>		12.1		0.476
D	1.5	1.6	0.059	0.063
D <sub>1</sub>	1.5		0.059	
E	1.65	1.85	0.065	0.073
F	7.4	7.6	0.291	0.299
K <sub>0</sub>	2.55	2.75	0.100	0.108
P <sub>0</sub>	3.9	4.1	0.153	0.161
P <sub>1</sub>	7.9	8.1	0.311	0.319
P <sub>2</sub>	1.9	2.1	0.075	0.082
R	40		1.574	
W	15.7	16.3	0.618	0.641

## 6 Revision history

**Table 13. Document revision history**

Date	Revision	Changes
14-Jun-2005	1	New release.
19-Jul-2005	2	Complete version.
27-Jan-2006	3	Inserted ecopack indication.
01-Mar-2006	4	The document has been reformatted.
08-Feb-2007	5	Modified value on <i>Table 6.: Switching on/off (inductive load)</i> .
24-Nov-2009	6	Inserted DPAK package option.

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